Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/555,646	VASILESCU ET AL.
Examiner	Art Unit

Nguyen N. Hanh

2834

	SEAR	CHED	
Class	Subclass	Date	Examiner
310	52	4/4/2007	HN
310	54	4/4/2007	. HN
310	58	4/4/2007	HN
310	64	4/4/2007	HN

INT	ERFERENC	E SEARCH	SEARCHED		
Class	Subclass	Date	Examiner		
	-				

	DATE	EXMR
-		
		<u>'</u>
	·	
,		